#### PD - 91342B

# IRF540NS IRF540NL

HEXFET® Power MOSFET

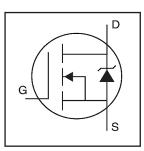
# International IOR Rectifier

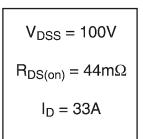
- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated

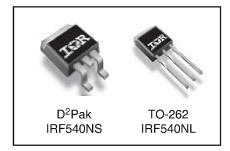
**Description**Advanced HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D<sup>2</sup>Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible onresistance in any existing surface mount package. The D<sup>2</sup>Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

The through-hole version (IRF540NL) is available for lowprofile applications.







#### **Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ⑦	33	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V ⑦	23	A
I <sub>DM</sub>	Pulsed Drain Current ①⑦	110	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	130	W
	Linear Derating Factor	0.87	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
I <sub>AR</sub>	Avalanche Current①	16	Α
E <sub>AR</sub>	Repetitive Avalanche Energy①	13	mJ
dv/dt	Peak Diode Recovery dv/dt ③⑦	7.0	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		_l ∘c
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	
	Mounting torque, 6-32 or M3 srew	10 lbf•in (1.1N•m)	

#### **Thermal Resistance**

	Parameter	Тур.	Max.	Units
R <sub>0</sub> JC	Junction-to-Case		1.15	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB mount)**		40	0, 11

## IRF540NS/IRF540NL

### Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.12		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA ⑦
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			44	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 16A ④
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
9fs	Forward Transconductance	21			S	V <sub>DS</sub> = 50V, I <sub>D</sub> = 16A⊕⑦
I <sub>DSS</sub>	Drain-to-Source Leakage Current			25	μA	V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V
צפטי	Brain to Godice Leakage Guiterit			250	μΛ	$V_{DS} = 80V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
1	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	''^	V <sub>GS</sub> = -20V
Q <sub>g</sub>	Total Gate Charge			71		I <sub>D</sub> = 16A
Q <sub>gs</sub>	Gate-to-Source Charge			14	nC	$V_{DS} = 80V$
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge			21		V <sub>GS</sub> = 10V, See Fig. 6 and 13 ④⑦
t <sub>d(on)</sub>	Turn-On Delay Time		11			V <sub>DD</sub> = 50V
t <sub>r</sub>	Rise Time		35		ns	I <sub>D</sub> = 16A
t <sub>d(off)</sub>	Turn-Off Delay Time		39		1115	$R_G = 5.1\Omega$
t <sub>f</sub>	Fall Time		35			V <sub>GS</sub> = 10V, See Fig. 10 ⊕⑦
L <sub>D</sub>	Internal Drain Inductance	4.5 -			Between lead,	
L-D	internal Drain Inductance		4.5		nH	6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5	_		from package
						and center of die contact
C <sub>iss</sub>	Input Capacitance		1960			V <sub>GS</sub> = 0V
Coss	Output Capacitance		250			$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		40		pF	$f = 1.0 \text{MHz}$ , See Fig. 5 $\bigcirc$
E <sub>AS</sub>	Single Pulse Avalanche Energy 27		700⑤	185©	mJ	I <sub>AS</sub> = 16A, L = 1.5mH

#### **Source-Drain Ratings and Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions						
Is	Continuous Source Current		33	20	MOSFET symbol							
	(Body Diode)			Α	showing the							
I <sub>SM</sub>	Pulsed Source Current				110	110	110	110	110	110		integral reverse
	(Body Diode)①		110	9	p-n junction diode.							
V <sub>SD</sub>	Diode Forward Voltage			1.2	V	$T_J = 25^{\circ}C$ , $I_S = 16A$ , $V_{GS} = 0V$ ④						
t <sub>rr</sub>	Reverse Recovery Time		115	170	ns	$T_J = 25^{\circ}C, I_F = 16A$						
Q <sub>rr</sub>	Reverse Recovery Charge		505	760	nC	di/dt = 100A/µs ④⑦						
t <sub>on</sub>	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )										

#### Notes:

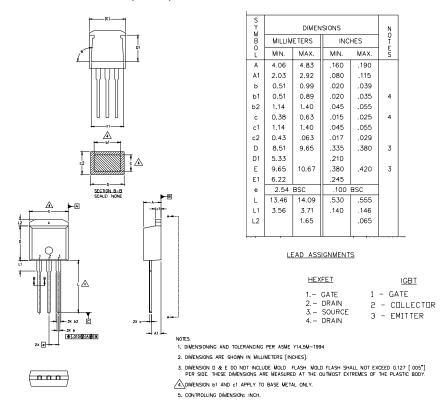
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting  $T_J = 25^{\circ}C$ , L = 1.5mH $R_G = 25\Omega$ ,  $I_{AS} = 16A$ . (See Figure 12)
- $\label{eq:loss} \begin{array}{l} \text{ } \exists \text{ } I_{SD} \leq 16\text{A, di/dt} \leq 340\text{A/}\mu\text{s, } V_{DD} \leq V_{(BR)DSS}, \\ T_{J} \leq 175^{\circ}\text{C} \end{array}$
- 4 Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- ⑤ This is a typical value at device destruction and represents operation outside rated limits.
- $\mbox{\ensuremath{\ensuremath{\mbox{\ensuremath{\mbox{\ensuremath{\mbox{\ensuremath{\mbox{\ensuremath{\mbox{\ensuremath{\mbox{\ensuremath{\mbox{\ensuremath{\mbox{\ensuremath}\ensuremat$
- ② Uses IRF540N data and test conditions.
- \*\*When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

# International TOR Rectifier

## IRF540NS/IRF540NL

### TO-262 Package Outline

Dimensions are shown in millimeters (inches)



### TO-262 Part Marking Information

